

Search Notes

Application/Control N .

10/531,956

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under
Reexamination

MAEDA ET AL.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
336	65, 83, 200, 232	5/29/2006	TTN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR